

## 1. Description

BLP12N10G, the N-channel Enhanced Power MOSFETs, is obtained by advanced double trench technology which reduce the conduction loss, and improve switching performance. This is suitable device for synchronous rectifier and high speed switching applications.

### KEY CHARACTERISTICS

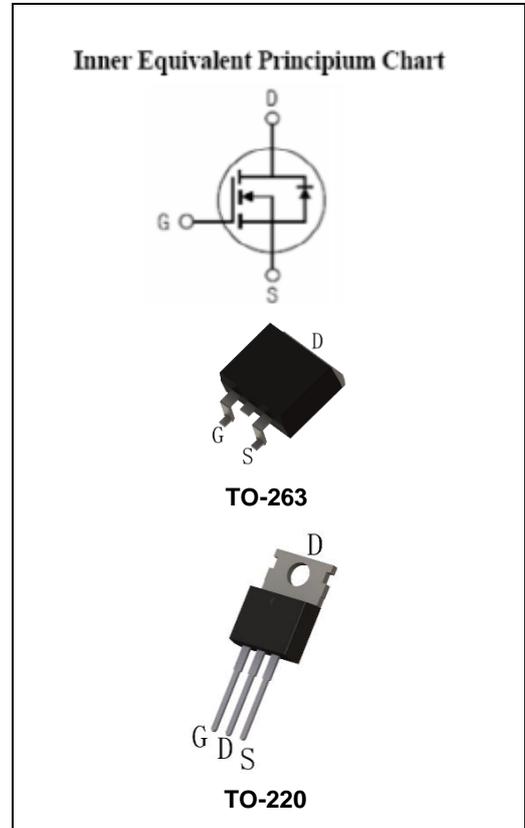
| Parameter               | Value | Unit |
|-------------------------|-------|------|
| V <sub>DSS</sub>        | 100   | V    |
| I <sub>D</sub>          | 55    | A    |
| R <sub>DS(on).typ</sub> | 10.5  | mΩ   |

### FEATURES

- Fast Switching
- Low On-Resistance (  $R_{DS(on)} \leq 12m\Omega$  )
- Low Gate Charge
- Low Reverse transfer capacitances
- High avalanche ruggedness
- RoHS product

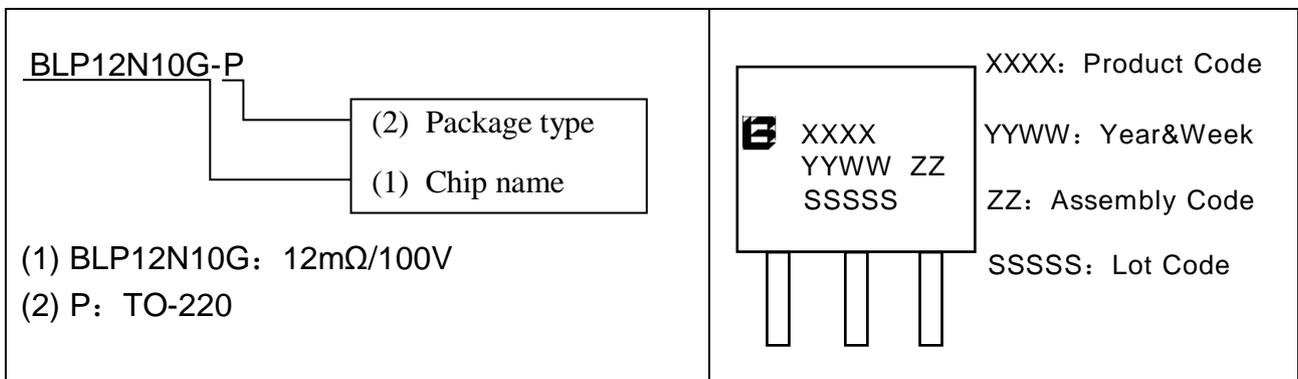
### APPLICATIONS

- Synchronous rectifiers
- High speed switching applications



## ORDERING INFORMATION

| Ordering Codes | Package | Product Code | Packing |
|----------------|---------|--------------|---------|
| BLP12N10G-B    | TO-263  | P12N10G      | Reel    |
| BLP12N10G-P    | TO-220  | P12N10G      | Tube    |



## 2. ABSOLUTE RATINGS

at  $T_C=25^\circ\text{C}$ , unless otherwise specified

| Symbol                    | Parameter  | Rating              | Units               |
|---------------------------|--|---------------------|---------------------|
| $V_{DSS}$                 | Drain-Source Voltage   | 100                 | V                   |
| $I_D$                     | Continuous Drain Current, Silicon Limited                            | 55                  | A                   |
|                           | Continuous Drain Current, Package Limited                            | 60                  | A                   |
|                           | Continuous Drain Current @ $T_C=100^\circ\text{C}$ , Silicon Limited | 35.1                | A                   |
| $I_{DM}$ <sup>Note1</sup> | Pulsed Drain Current   | 220                 | A                   |
| $V_{GS}$                  | Gate-Source Voltage  | $\pm 20$            | V                   |
| $E_{AS}$ <sup>Note2</sup> | Avalanche Energy   | 56.25               | mJ                  |
| $P_D$                     | Power Dissipation  | 69.4                | W                   |
|                           | Derating Factor above $25^\circ\text{C}$                             | 0.56                | W/ $^\circ\text{C}$ |
| $T_J, T_{stg}$            | Operating Junction and Storage Temperature Range                     | 150, $-55$ to $150$ | $^\circ\text{C}$    |
| $T_L$                     | Maximum Temperature for Soldering                                    | 260                 | $^\circ\text{C}$    |

Note1: Repetitive Rating: Pulse width limited by maximum junction temperature

Note2:  $L=0.5\text{mH}$ ,  $I_{as}=15\text{A}$ , Start  $T_J=25^\circ\text{C}$

## 3. Thermal characteristics

| Symbol          | Parameter                            | Max  | Units                     |
|-----------------|--------------------------------------|------|---------------------------|
| $R_{\theta JC}$ | thermal resistance, Junction-Case    | 1.8  | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | thermal resistance, Junction-Ambient | 62.5 | $^\circ\text{C}/\text{W}$ |

## 4. Electrical Characteristics

at  $T_C=25^\circ\text{C}$ , unless otherwise specified

| OFF Characteristics |                                |   |        |     |      |               |
|---------------------|--------------------------------|---|--------|-----|------|---------------|
| Symbol              | Parameter                      | Test Conditions   | Values |     |      | Units         |
|                     |                                |   | Min    | Typ | Max  |               |
| $V_{DSS}$           | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$                             | 100    | 110 | --   | V             |
| $I_{DSS}$           | Drain-Source Leakage Current   | $V_{DS}=100\text{V}$ , $V_{GS}=0\text{V}$                             | --     | --  | 1    | $\mu\text{A}$ |
|                     |                                | $V_{DS}=80\text{V}$ , $V_{GS}=0\text{V}$<br>@ $T_C=125^\circ\text{C}$ | --     | --  | 100  | $\mu\text{A}$ |
| $I_{GSS(F)}$        | Gate-Source Forward Leakage    | $V_{GS}=+20\text{V}$  | --     | --  | 100  | nA            |
| $I_{GSS(R)}$        | Gate-Source Reverse Leakage    | $V_{GS}=-20\text{V}$  | --     | --  | -100 | nA            |

## ON Characteristics

| Symbol       | Parameter                  | Test Conditions               | Values |      |     | Unit<br>S |
|--------------|----------------------------|-------------------------------|--------|------|-----|-----------|
|              |                            |                               | Min    | Typ  | Max |           |
| $R_{DS(on)}$ | Drain-Source On-Resistance | $V_{GS}=10V, I_D=20A$         | --     | 10.5 | 12  | $m\Omega$ |
| $V_{GS(th)}$ | Gate Threshold Voltage     | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2      | 3    | 4   | V         |

Pulse width  $t_p \leq 300\mu s, \delta \leq 2\%$

## Dynamic Characteristics

| Symbol    | Parameter                    | Test Conditions                   | Values |      |     | Units    |
|-----------|------------------------------|-----------------------------------|--------|------|-----|----------|
|           |                              |                                   | Min    | Typ  | Max |          |
| $C_{iss}$ | Input Capacitance            | $V_{DS}=50V, V_{GS}=0, f=1MHz$    | --     | 1680 | --  | pF       |
| $C_{oss}$ | Output Capacitance           |                                   | --     | 271  | --  |          |
| $C_{rss}$ | Reverse Transfer Capacitance |                                   | --     | 10   | --  |          |
| $Q_g$     | Total Gate Charge            | $V_{DD}=50V, I_D=20A, V_{GS}=10V$ | --     | 37   | --  | nC       |
| $Q_{gs}$  | Gate-Source charge           |                                   | --     | 10.2 | --  |          |
| $Q_{gd}$  | Gate-Drain charge            |                                   | --     | 11.3 | --  |          |
| $R_G$     | Gate resistance              | $V_{GS}=0, V_{DS}=0$              |        | 1.3  |     | $\Omega$ |

## Switching Characteristics

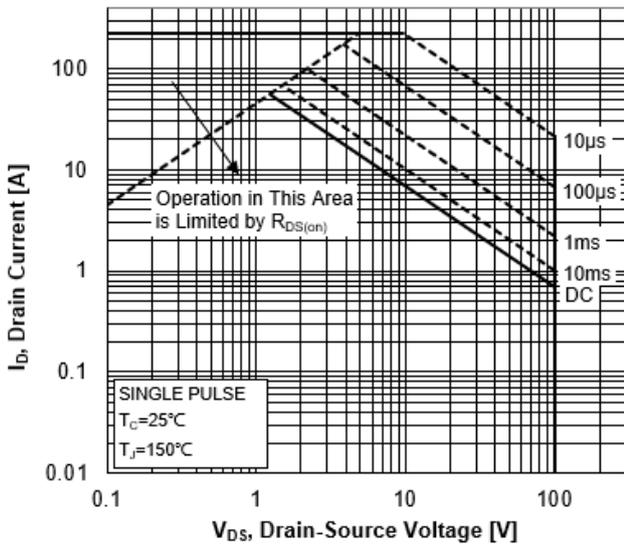
| Symbol       | Parameter           | Test Conditions   | Values |      |     | Units |
|--------------|---------------------|---|--------|------|-----|-------|
|              |                     |   | Min    | Typ  | Max |       |
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD}=50V, I_D=10A, V_{GS}=10V, R_G=5\Omega, \text{Resistive Load}$ | --     | 14.4 | --  | ns    |
| $t_r$        | Rise Time           |   | --     | 13   | --  |       |
| $t_{d(off)}$ | Turn-Off Delay Time |   | --     | 28.8 | --  |       |
| $t_f$        | Fall Time           |   | --     | 15.2 | --  |       |

## Source-Drain Diode Characteristics

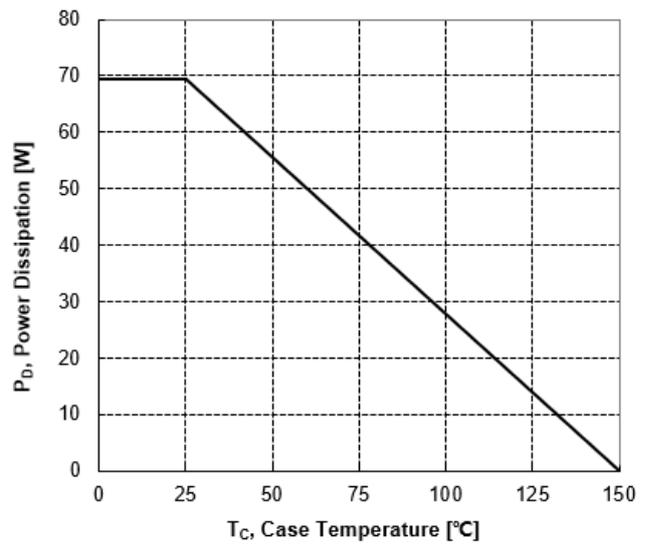
| Symbol   | Parameter                 | Test Conditions                    | Values |       |     | Units |
|----------|---------------------------|------------------------------------|--------|-------|-----|-------|
|          |                           |                                    | Min    | Typ   | Max |       |
| $I_S$    | Continuous Source Current |                                    | --     | --    | 55  | A     |
| $I_{SM}$ | Maximum Pulsed Current    |                                    | --     | --    | 220 | A     |
| $V_{SD}$ | Diode Forward Voltage     | $V_{GS}=0V, I_S=20A$               | --     | --    | 1.2 | V     |
| $T_{rr}$ | Reverse Recovery Time     | $I_S=10A, V_{GS}=0, di/dt=250A/us$ | --     | 168   | --  | ns    |
| $Q_{rr}$ | Reverse Recovery Charge   |                                    | --     | 335.8 | --  | nC    |

**5. Characteristics Curves**

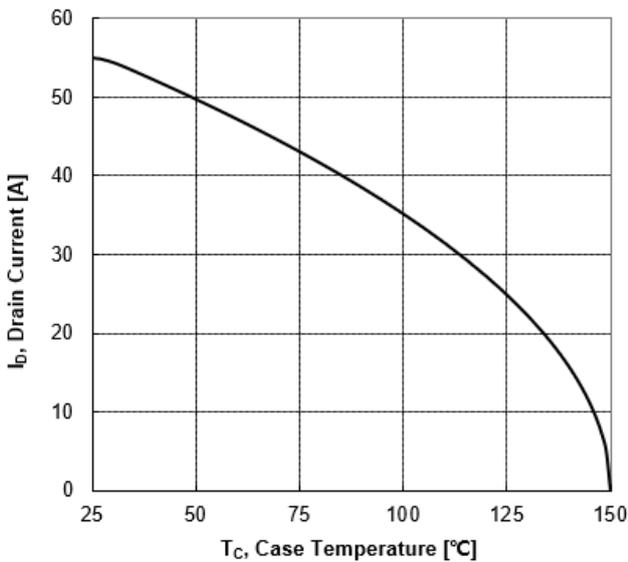
**Figure 1. Safe Operating Area**



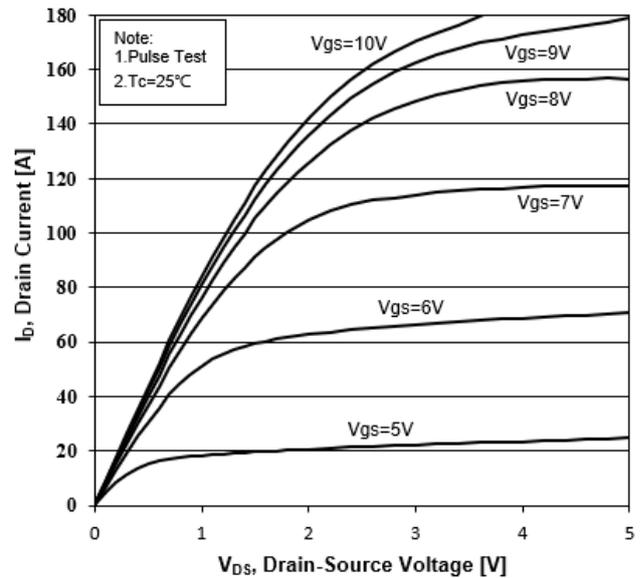
**Figure 2. Maximum Power Dissipation vs Case Temperature**



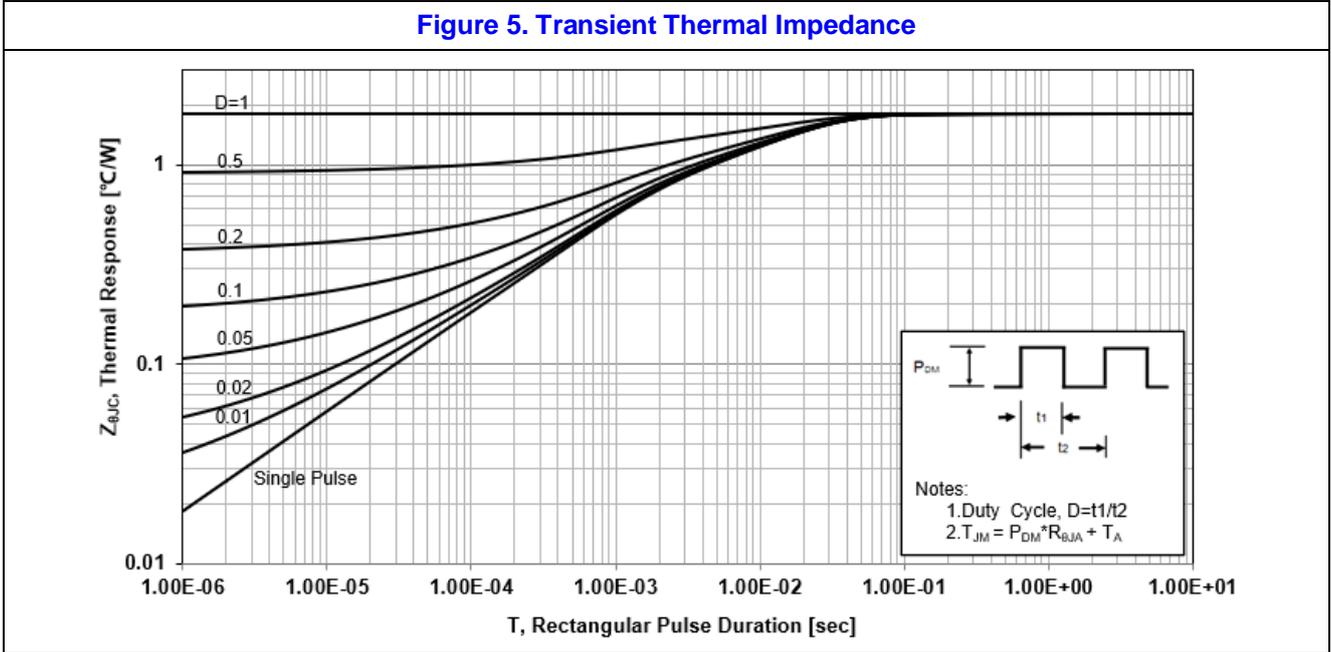
**Figure 3. Maximum Continuous Drain Current vs Case Temperature**



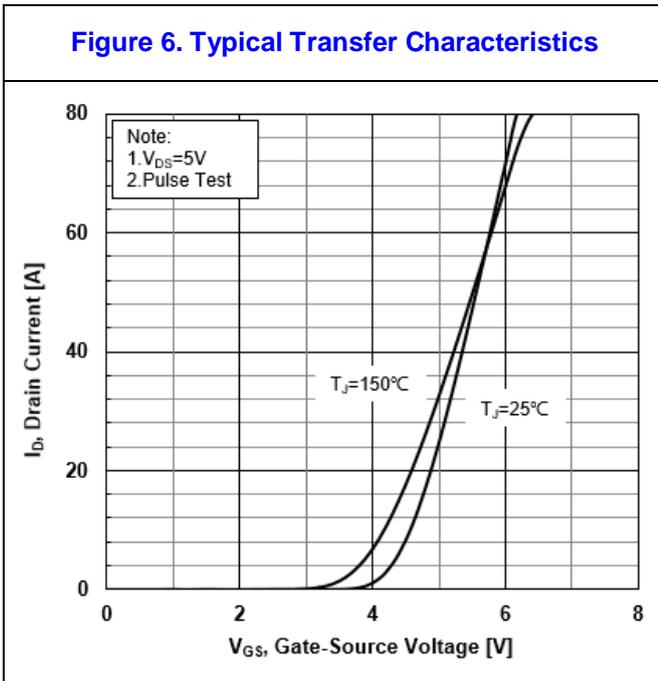
**Figure 4. Typical Output Characteristics**



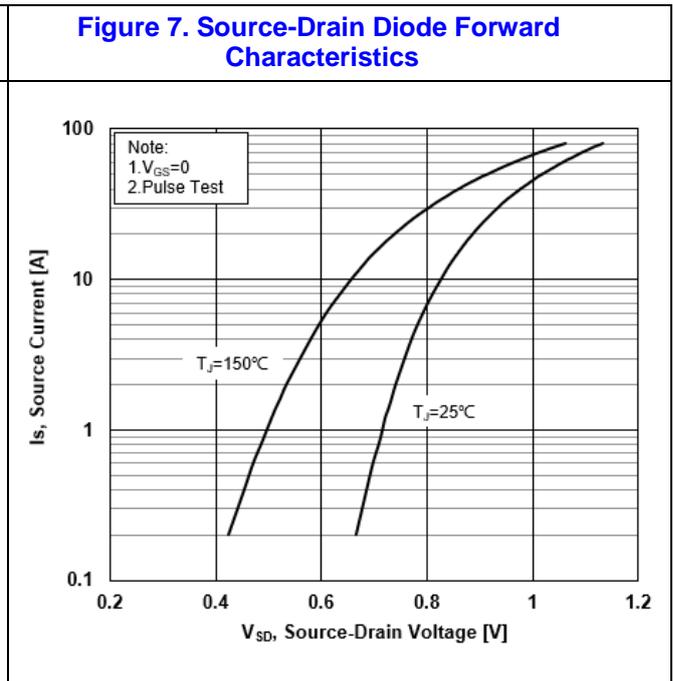
**Figure 5. Transient Thermal Impedance**



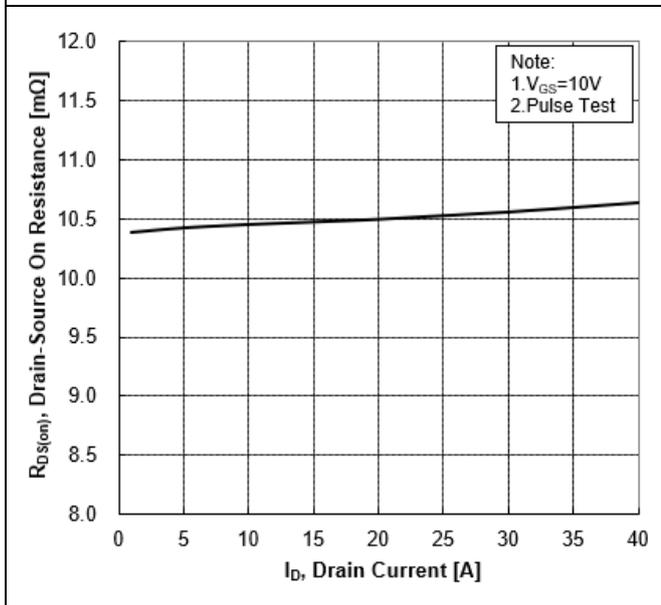
**Figure 6. Typical Transfer Characteristics**



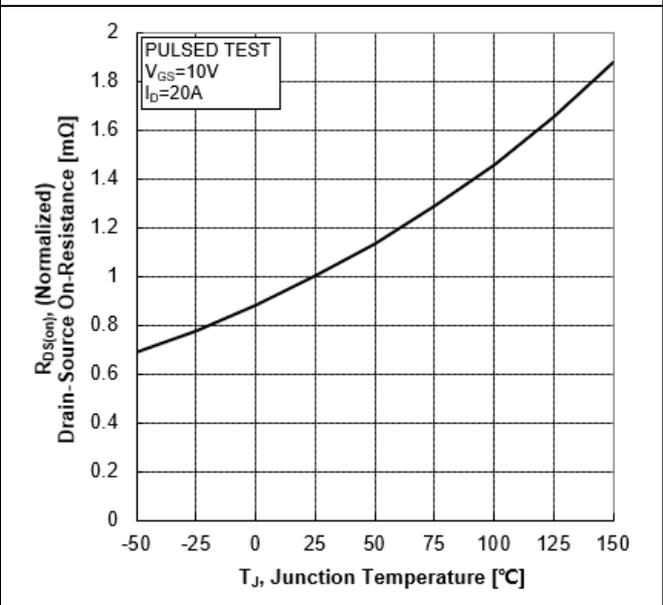
**Figure 7. Source-Drain Diode Forward Characteristics**



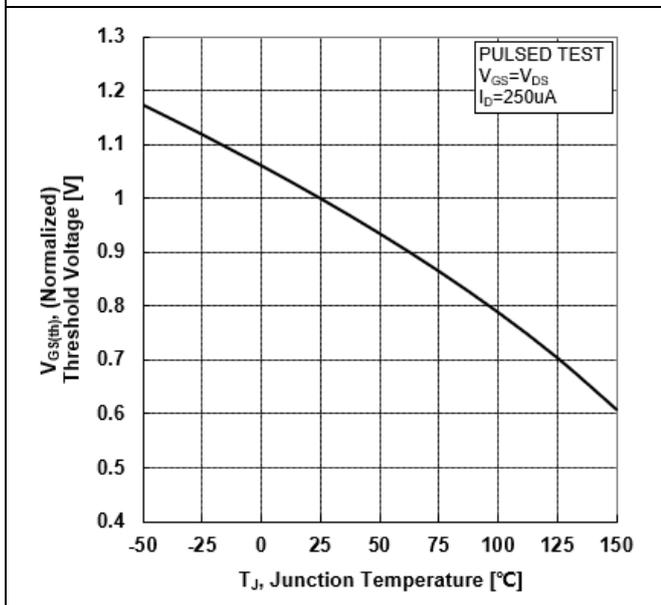
**Figure 8. Drain-Source On-Resistance vs Drain Current**



**Figure 9. Normalized On-Resistance vs Junction Temperature**



**Figure 10. Normalized Threshold Voltage vs Junction Temperature**



**Figure 11. Normalized Breakdown Voltage vs Junction Temperature**

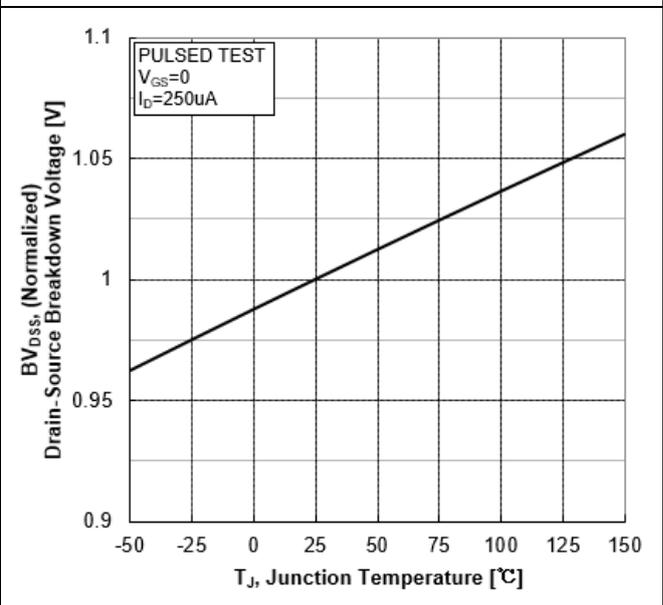


Figure 12. Capacitance Characteristics

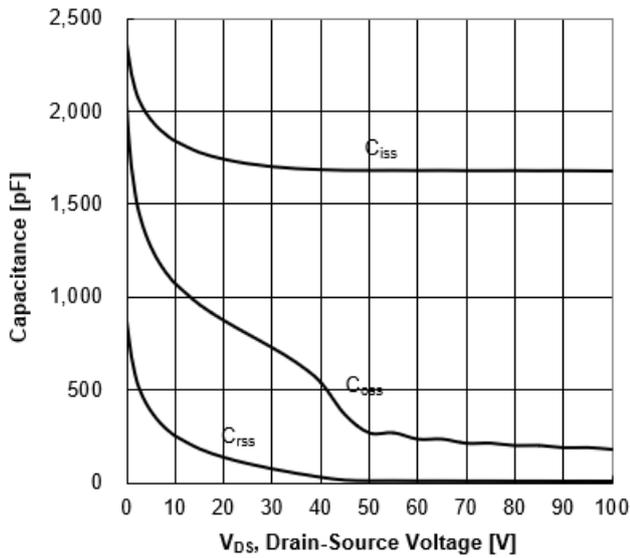
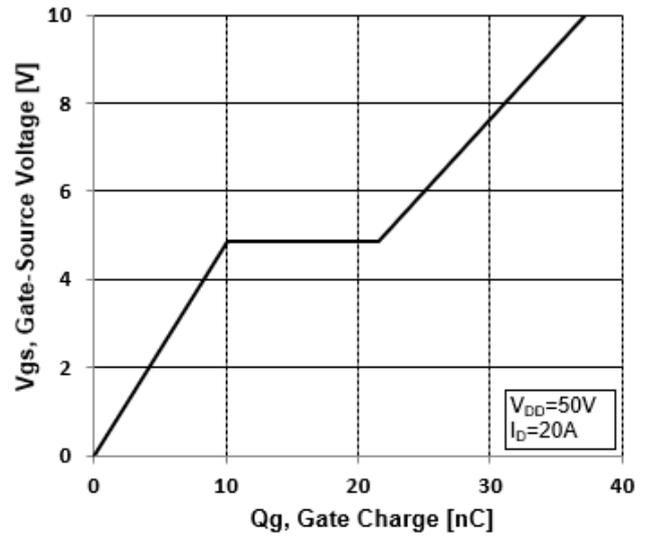
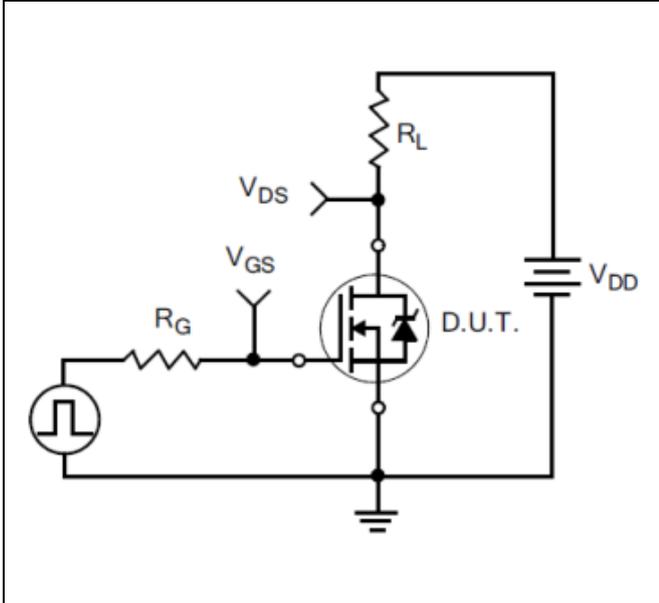


Figure 13. Typical Gate Charge vs Gate-Source Voltage

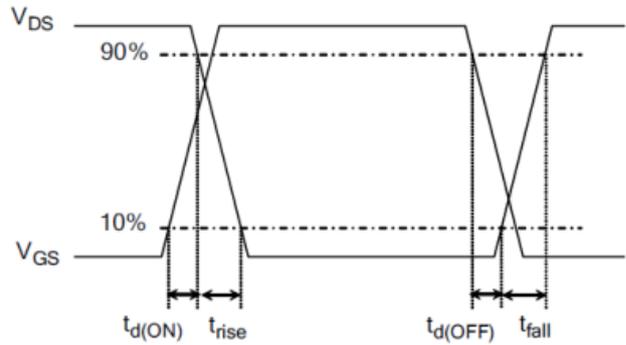


**6. Test Circuit and Waveform**

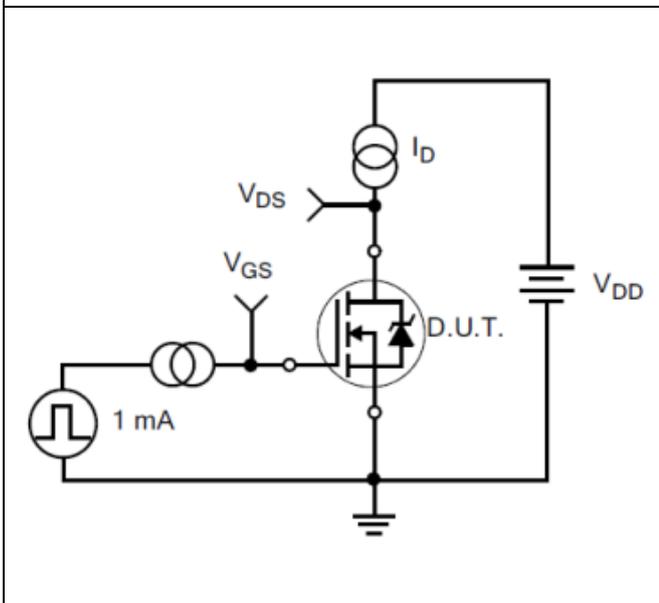
**Figure 14. Resistive Switching Test Circuit**



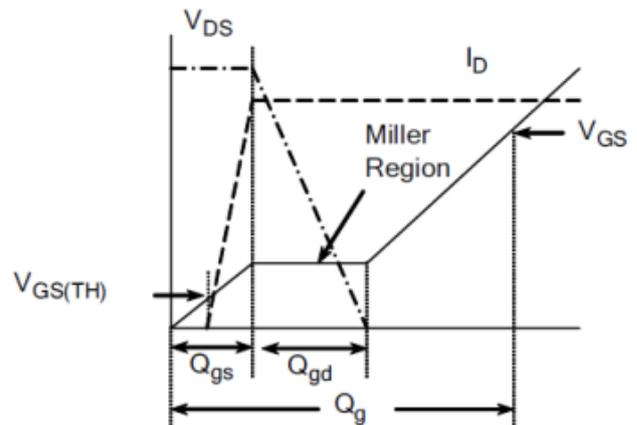
**Figure 15. Resistive Switching Waveforms**

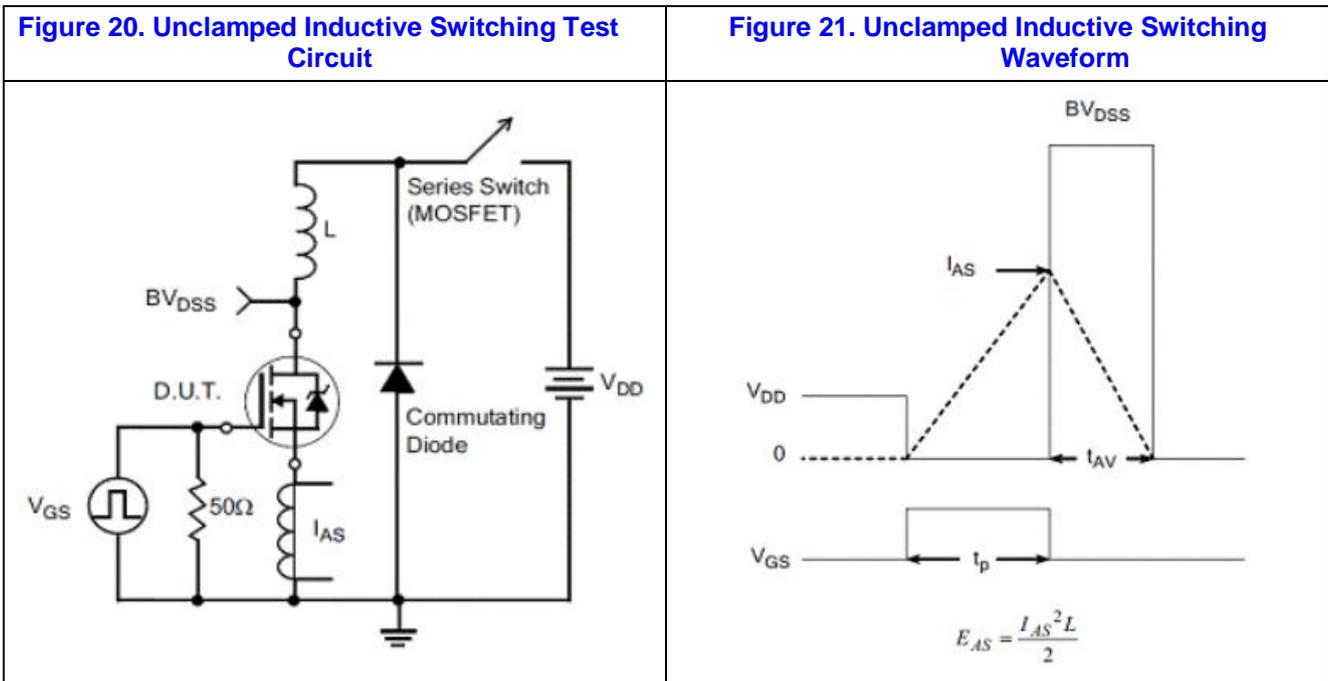
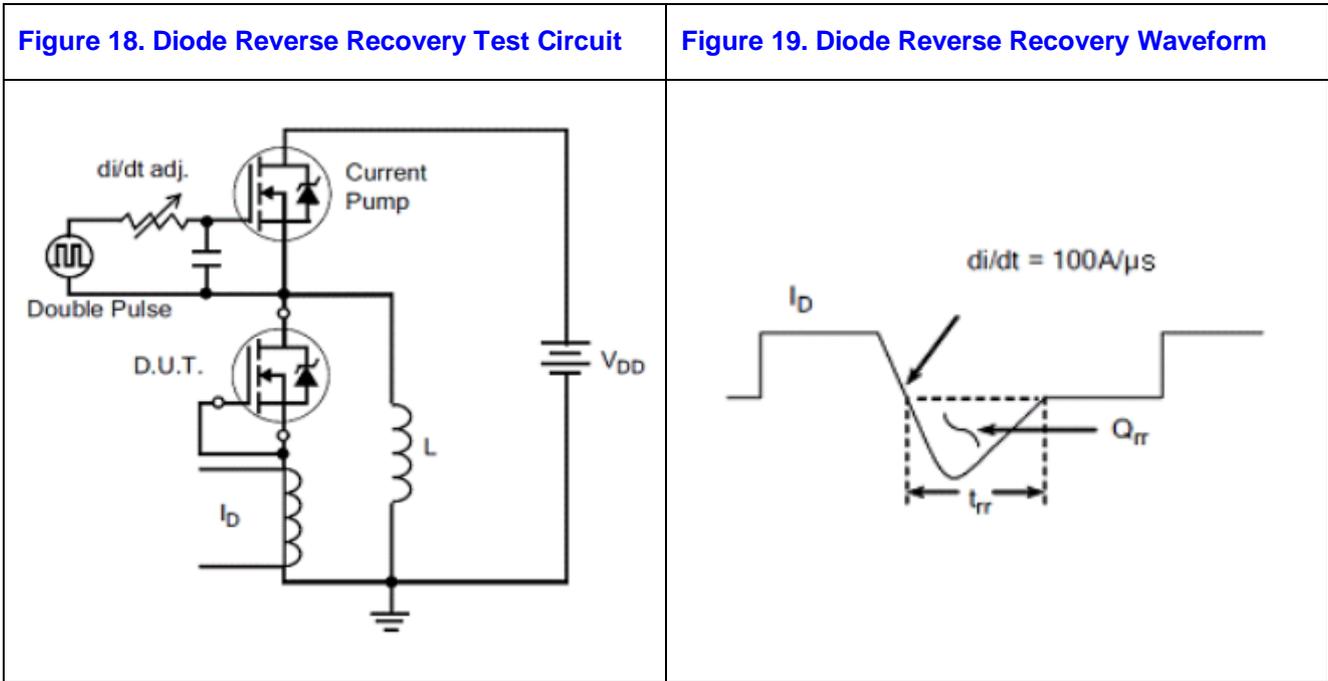


**Figure 16. Gate Charge Test Circuit**



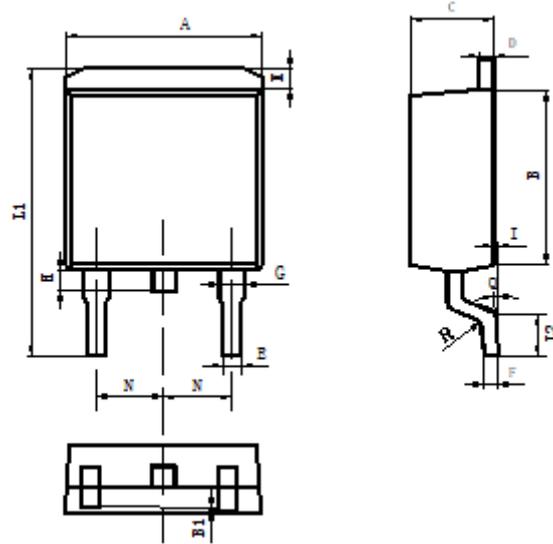
**Figure 17. Gate Charge Waveforms**





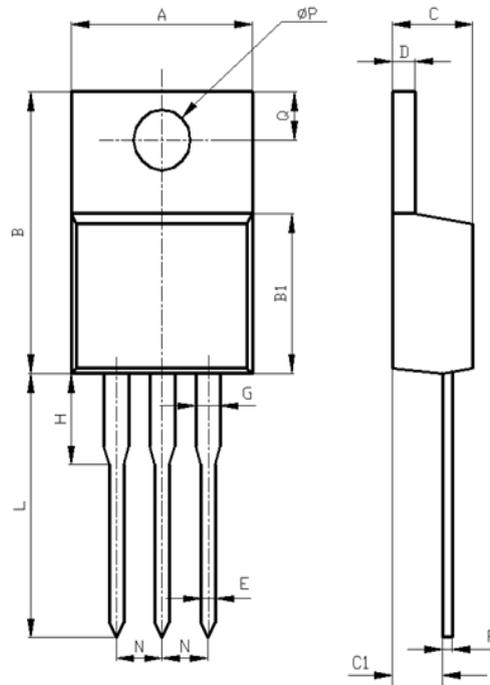
## 7. Package Description

### TO-263 Package



| Items | Values(mm) |       |
|-------|------------|-------|
|       | MIN        | MAX   |
| A     | 9.80       | 10.40 |
| B     | 8.90       | 9.50  |
| B1    | 0          | 0.10  |
| C     | 4.40       | 4.80  |
| D     | 1.16       | 1.37  |
| E     | 0.70       | 0.95  |
| F     | 0.30       | 0.60  |
| G     | 1.07       | 1.47  |
| H     | 1.30       | 1.80  |
| K     | 0.95       | 1.37  |
| L1    | 14.50      | 16.50 |
| L2    | 1.60       | 2.30  |
| I     | 0          | 0.2   |
| Q     | 0°         | 8°    |
| R     | 0.4        | 0.4   |
| N     | 2.39       | 2.69  |

TO-220 Package



| Items    | Values(mm) |      |
|----------|------------|------|
|          | MIN        | MAX  |
| A        | 9.60       | 10.6 |
| B        | 15.0       | 16.0 |
| B1       | 8.90       | 9.50 |
| C        | 4.30       | 4.80 |
| C1       | 2.30       | 3.10 |
| D        | 1.20       | 1.40 |
| E        | 0.70       | 0.90 |
| F        | 0.30       | 0.60 |
| G        | 1.17       | 1.37 |
| H        | 2.70       | 3.80 |
| L        | 12.6       | 14.8 |
| N        | 2.34       | 2.74 |
| Q        | 2.40       | 3.00 |
| $\Phi P$ | 3.50       | 3.90 |

**NOTE:**

1. Exceeding the maximum ratings of the device in performance may cause damage to the device,

even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.

2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shanghai Belling reserves the right to make changes in this specification sheet and is subject to change without prior notice.

## CONTACT:

### 上海贝岭股份有限公司 (总部)

地址: 上海市宜山路 810 号

邮编: 200233

电话: 021-24261000

### 产品业务咨询及技术支持

电话: 021-24261326

传真: 021-64852222

邮箱: marketing@belling.com.cn

### 上海贝岭深圳分公司 (华南区)

地址: 深圳市福田区中心区民田路新华保险大厦 1510 室

邮编: 518031

电话: 0755-33336776 0755-33336770

传真: 0755-33336788

### 上海贝岭北京办事处 (华北区)

地址: 北京市西城区新华里 16 号院锦官苑小区 10 号楼 1 单元 1505 室

邮编: 100044

电话: 010-64179374

传真: 010-8835 9236